


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582440	<b>Applicant(s)/Patent Under Reexamination</b>  CHO ET AL.
	<b>Examiner</b>  QUN SHEN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	411, 466, 450, 410	11/4/09	QS

SEARCH NOTES		
Search Notes	Date	Examiner
Text search on EAST	11/1/09	QS
Google patent search	11/1/09	QS
International search report	11/04/09	QS
Inventor search	11/4/09	QS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner,Art Unit 2617